

Search Notes

Application/Control No.

10/790,880

Examiner

Denise Tran

Applicant(s)/Patent under
Reexamination

AKIYAMA ET AL.

Art Unit

2189

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
text	USPGPUB	7/30/2009	DT
text	USPAT	7/30/2009	DT
text	UPAD	7/30/2009	DT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (USPAT, USPGPUB,USOCR,EPOAB,JPOAB,D ERWENT, IBM-TDB)	7/27/2009	DT
711/5,118,170,128-129,104,144; 365/230.03,185.11 (text search only search history)	7/30/2009	DT
711/103,105, 167; 365/189.01 (text search only search history)	7/27/2009	DT
inventor name search	7/27/2009	DT
IEEE search	7/30/2009	DT
interference search (see search history)	7/30/2009	DT